

Search Notes

Application/Control No.

10/829,232

Examiner

Shih-wen Hsieh


Applicant(s)/Patent under
Reexamination

NISHIOKA, ATSUSHI

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22-35	5/13/2005	 SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR